

# Tilted window: ray propagation

- Calculate phase shift caused by the insertion of the window into an interferometer.
- Ray optics:
  - Add up optical path for each segment
  - Subtract optical path w/o window

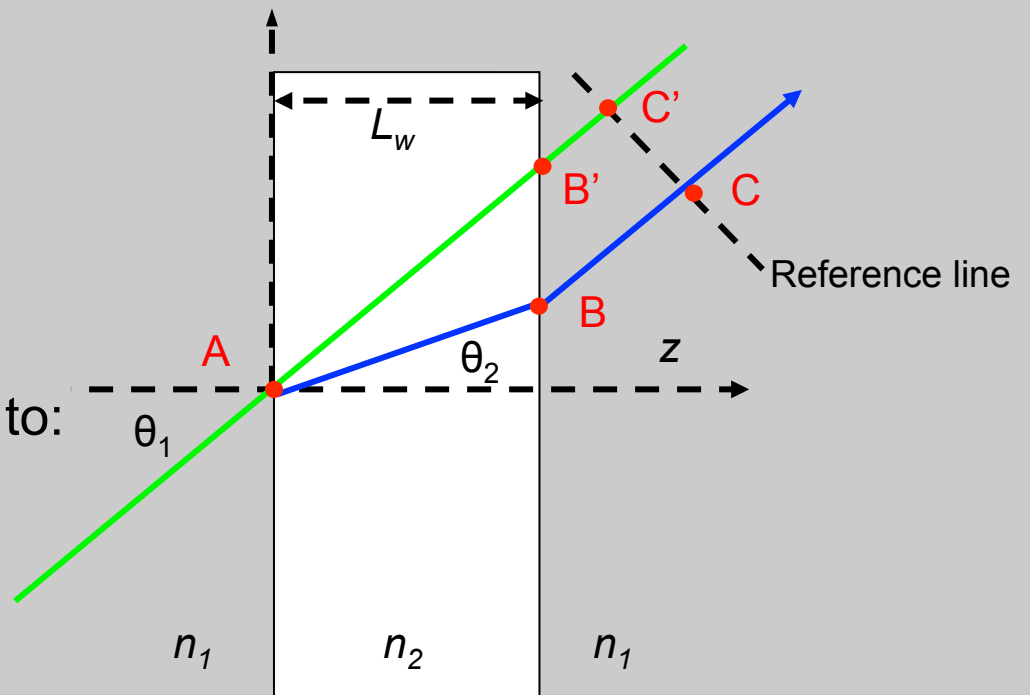
$$\Delta d = nL_{AB} + L_{BC} - L_{AB'} - L_{B'C'}$$

$$L_{AB} = \frac{L_w}{\cos \theta_2} \quad L_{AB'} = \frac{L_w}{\cos \theta_1}$$

$$L_{BC} = L_{B'C'} + L_{BB'} \sin \theta_1$$

- Use Snell's Law to reduce to:

$$\Delta d = n L_w \cos \theta_2 - L_w \cos \theta_1$$



# Tilted window: wave propagation

- Write expression for tilted plane wave

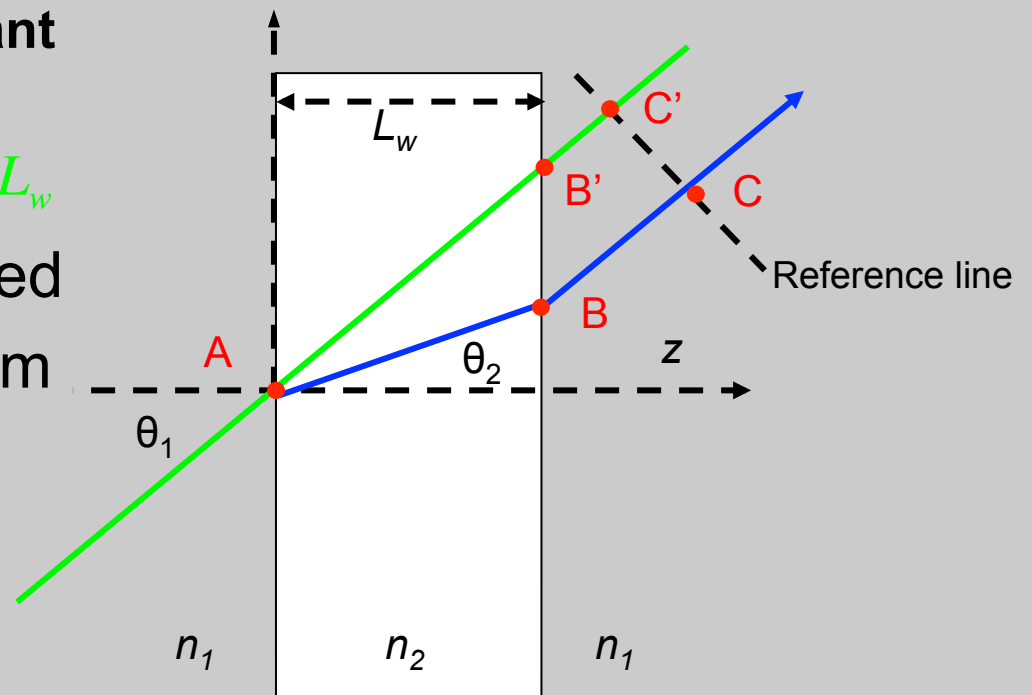
$$E(x, z) = E_0 \exp\left[i(k_x x + k_z z)\right] = E_0 \exp\left[i \frac{\omega}{c} n (x \sin \theta_2 + z \cos \theta_2)\right]$$

- Snell's Law: phase across surfaces is conserved

$$k_x x = \frac{\omega}{c} n \sin \theta \quad \text{is constant}$$

$$\Delta\phi = (k_2 \cos \theta_2) L_w - (k_1 \cos \theta_1) L_w$$

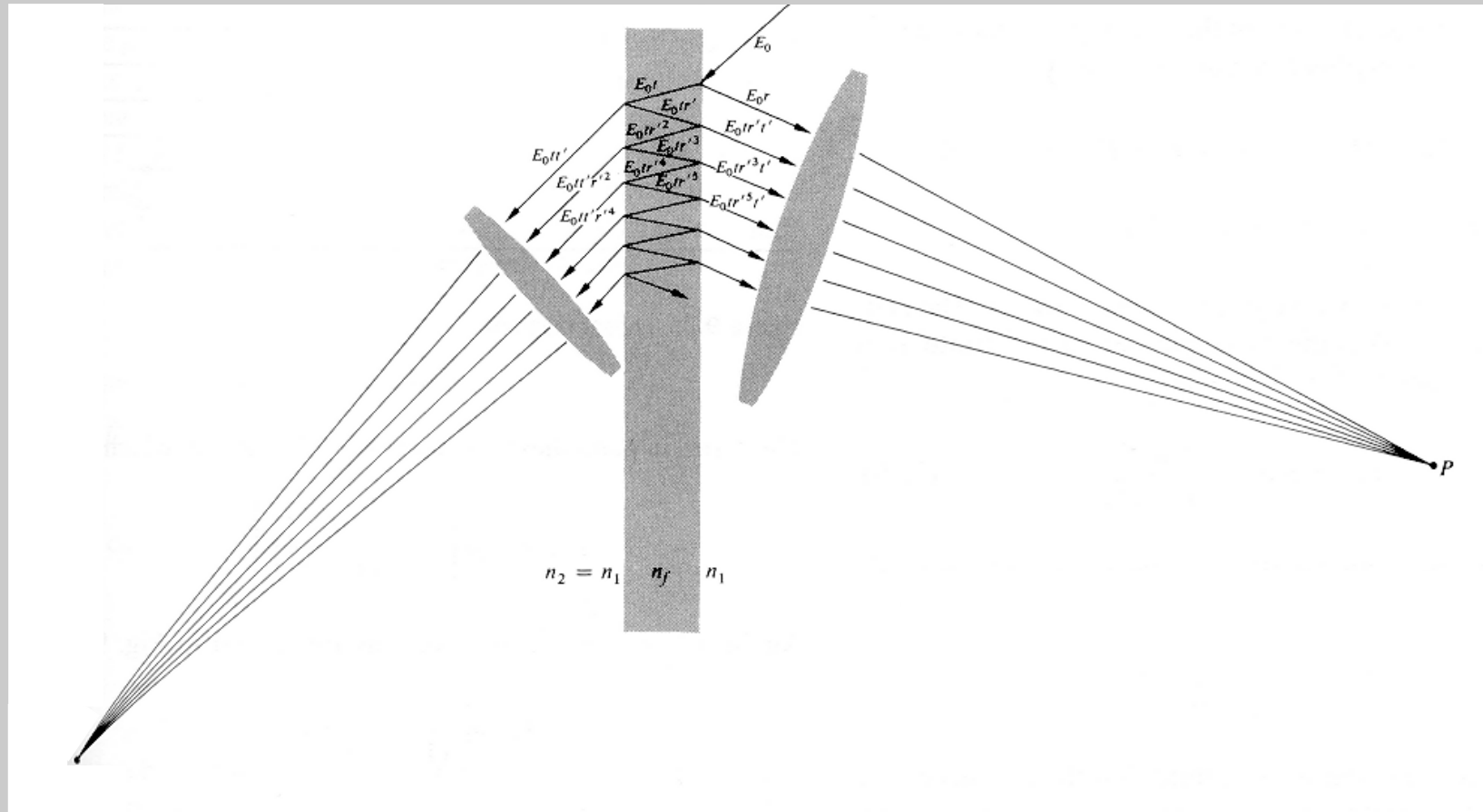
- This approach can be used to calculate phase of prism pairs and grating pairs



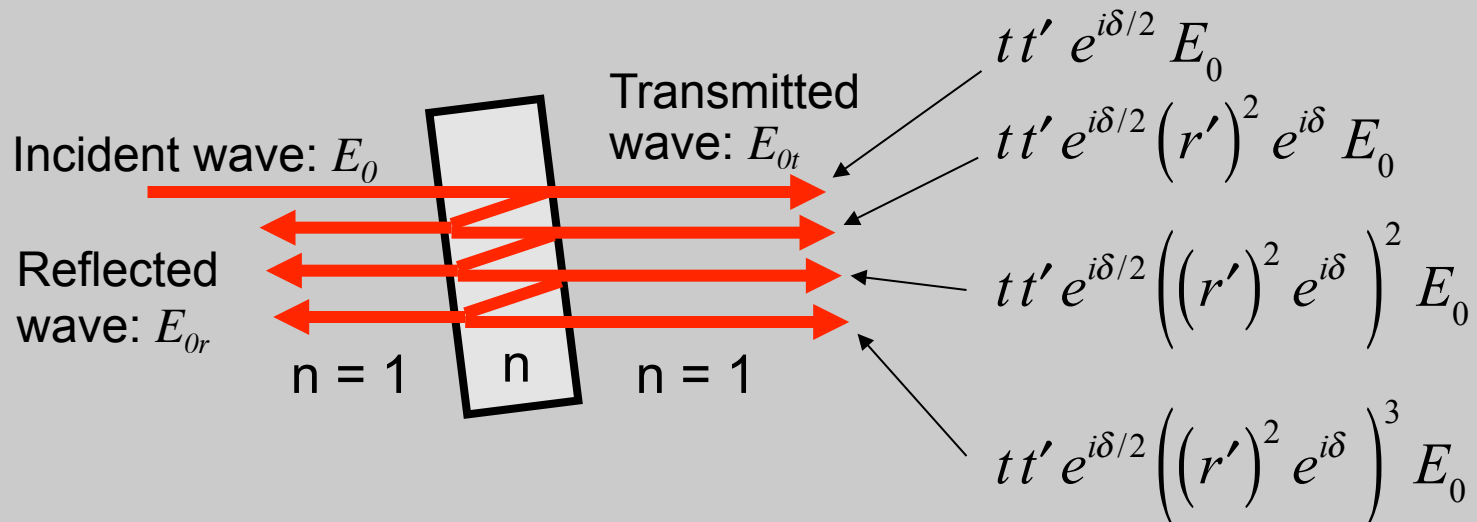
# Multiple-beam interference: The Fabry-Perot Interferometer or Etalon

A Fabry-Perot interferometer is a pair of **parallel** surfaces that reflect beams back and forth. An etalon is a type of Fabry-Perot etalon, and is a piece of glass with parallel sides.

The transmitted wave is an infinite series of multiply reflected beams.



# Multiple-beam interference: general formulation



$r, t$  = reflection, transmission coefficients from air to glass  
 $r', t'$  = “ “ “ from glass to air

$\delta$  = round-trip phase delay inside medium =  $k_0(2 n L \cos \theta_t)$

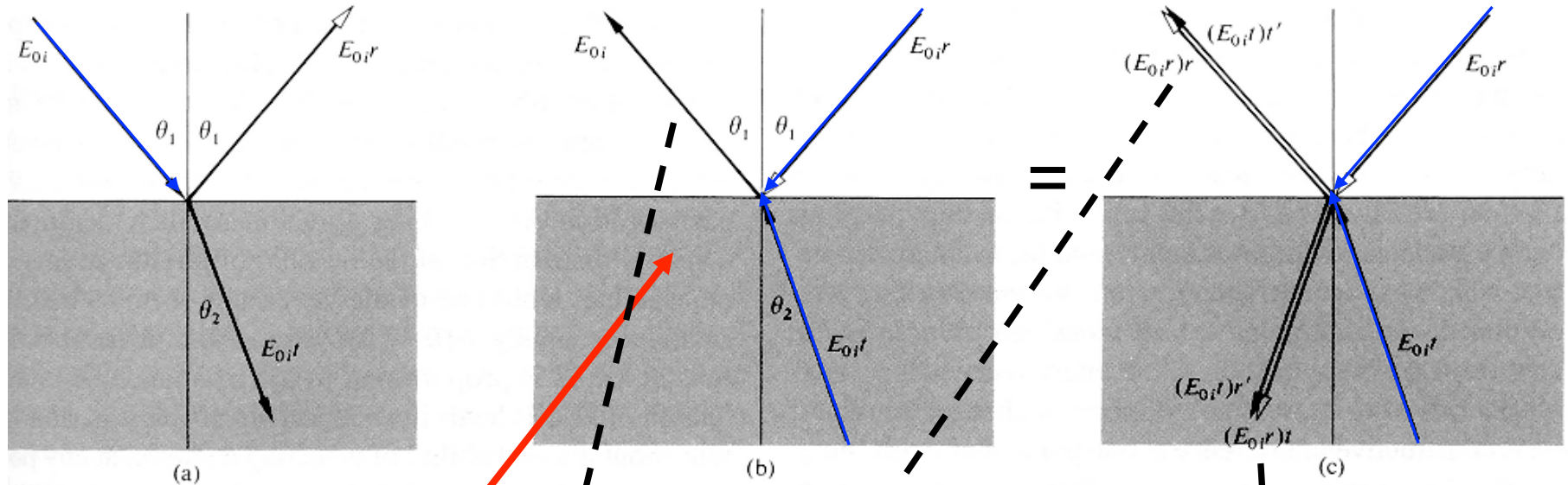
Transmitted wave:

$$E_{0t} = tt' e^{-i\delta/2} E_0 \left( 1 + (r')^2 e^{i\delta} + \left( (r')^2 e^{i\delta} \right)^2 + \left( (r')^2 e^{i\delta} \right)^3 + \dots \right)$$

Reflected wave:

$$E_{0r} = rE_0 + tt'r'e^{i\delta} E_0 + tt'r' \left( (r')^2 e^{i\delta} \right)^2 E_0 + \dots$$

# Stokes Relations for reflection and transmission



“Time reversal:”  
Same amplitudes,  
reversed propagation  
direction

$$E_{oi} = (E_{oi}r)r + (E_{oi}t)t'$$

$$\therefore tt' = 1 - r^2$$

$$(E_{oi}t)r' + (E_{oi}r)t = 0$$

$$\therefore r' = -r$$

## Notes:

- relations apply to angles connected by Snell's Law
- true for any polarization, but not TIR
- convention for which interface experiences a sign change can vary

# Fabry-Perot transmission

Stokes' relations

$$r' = -r$$

$$r'^2 = r^2$$

$$tt' = 1 - r^2$$

The transmitted wave field is:

$$E_{0t} = tt'e^{i\delta/2} E_0 \left( 1 + (r')^2 e^{i\delta} + \left( (r')^2 e^{i\delta} \right)^2 + \left( (r')^2 e^{i\delta} \right)^3 + \dots \right)$$

$$= tt'e^{i\delta/2} E_0 \left( 1 + r^2 e^{i\delta} + \left( r^2 e^{i\delta} \right)^2 + \left( r^2 e^{i\delta} \right)^3 + \dots \right)$$

Where:

$$\Rightarrow E_{0t} = tt'E_0 / (1 - r^2 e^{-i\delta})$$

$$(1-x)^{-1} = 1 + x + x^2 + x^3 + \dots$$

Power transmittance:  $T \equiv \left| \frac{E_{0t}}{E_0} \right|^2 = \left| \frac{tt'e^{i\delta/2}}{1 - r^2 e^{i\delta}} \right|^2 = \frac{(tt')^2}{(1 - r^2 e^{+i\delta})(1 - r^2 e^{-i\delta})}$

$$= \left[ \frac{(tt')^2}{\{1 + r^4 - 2r^2 \cos(\delta)\}} \right] = \left[ \frac{(1-r^2)^2}{\{1 + r^4 - 2r^2[1 - 2\sin^2(\delta/2)]\}} \right] = \left[ \frac{(1-r^2)^2}{\{1 - 2r^2 + r^4 + 4r^2 \sin^2(\delta/2)\}} \right]$$

Dividing numerator and denominator by  $(1 - r^2)^2$

$$T = \frac{1}{1 + F \sin^2(\delta/2)}$$

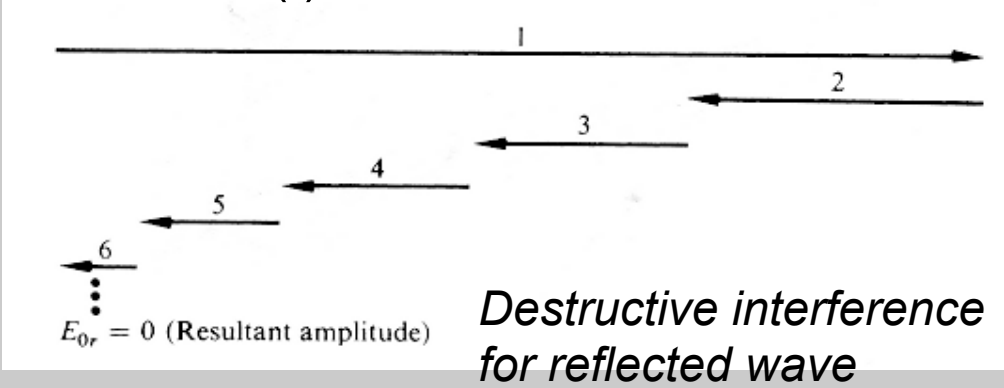
where:  $F = \left[ \frac{2r}{1 - r^2} \right]^2$

# Multiple-beam interference: simple limits

## Reflected waves

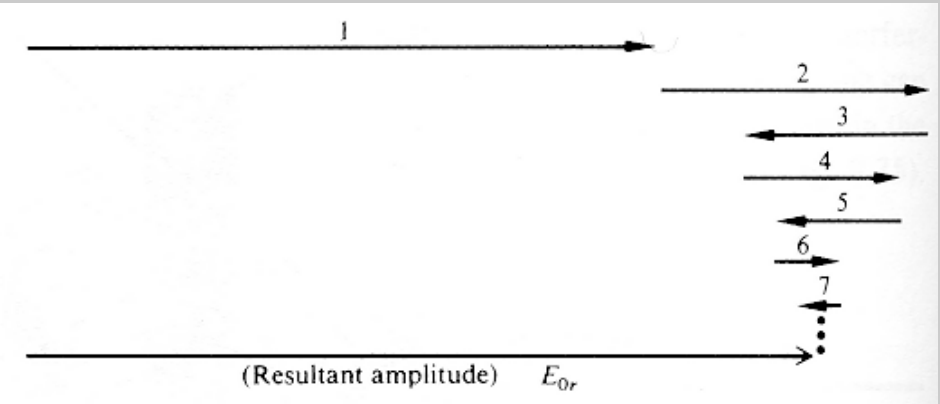
$$T = \frac{1}{1 + F \sin^2(\delta / 2)}$$

Full transmission:  $\sin(\delta) = 0, d = 2 \pi m$



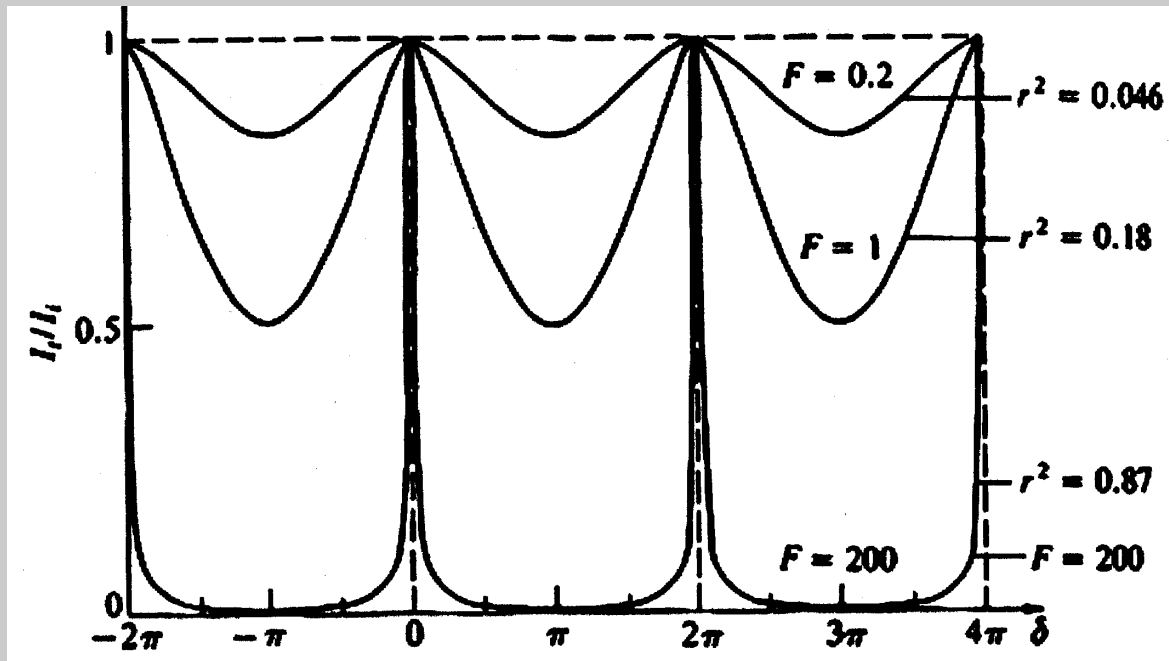
1st reflection  
internal reflections

Minimum transmission:  $\sin(\delta) = 1, d = 2 \pi (m + 1/2)$



*Constructive interference for reflected wave*

# Etalon transmittance vs. thickness, wavelength, or angle



$$T = \frac{1}{1 + F \sin^2(\delta / 2)}$$

Transmission max:  
 $\sin(\ ) = 0$ ,  $d = 2 \pi m$

$$\delta = \frac{\omega}{c} 2 n L \cos[\theta_t]$$

$$= 2 \pi m$$

At normal incidence:

$$\lambda_m = \frac{2 n L}{m} \quad \text{or} \quad n L = m \frac{\lambda_m}{2}$$

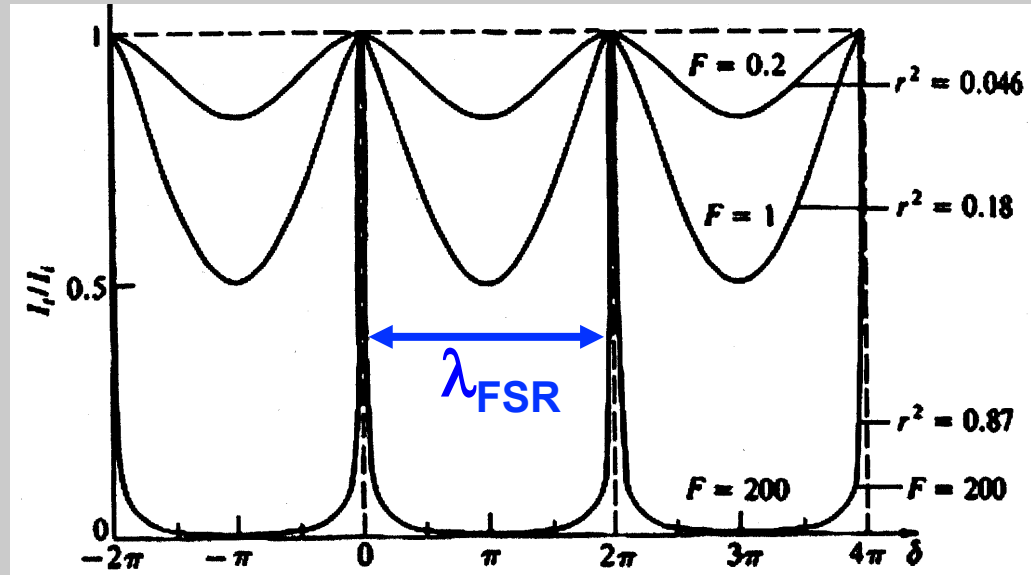
- The transmittance varies significantly with thickness or wavelength.
- We can also vary the incidence angle, which also affects  $\delta$ .
- As the reflectance of each surface ( $R=r^2$ ) approaches 1, the widths of the high-transmission regions become very narrow.



# The Etalon Free Spectral Range

The Free Spectral Range is the wavelength range between transmission maxima.

$$\lambda_{FSR} = \text{Free Spectral Range}$$



For neighboring orders:

$$\frac{4\pi nL}{\lambda_1} - \frac{4\pi nL}{\lambda_2} = 2\pi \Rightarrow \frac{1}{\lambda_1} - \frac{1}{\lambda_2} = \frac{1}{2nL} = \frac{\lambda_2 - \lambda_1}{\lambda_1 \lambda_2}$$

$$\lambda_2 - \lambda_1 = \lambda_{FSR}$$

$$\lambda_2 \lambda_1 \approx \lambda^2$$

$$\lambda_{FSR} \approx \frac{\lambda^2}{2nL}$$

$$\frac{\lambda_{FSR}}{\lambda} = \frac{\lambda}{2nL} = \frac{\nu_{FSR}}{\nu}$$

$$\nu_{FSR} \approx \frac{c}{2nL}$$

1/(round trip time)

# Etalon Linewidth

The **Linewidth**  $\delta_{LW}$  is a transmittance peak's full-width-half-max (FWHM).

$$T = \frac{1}{1 + F \sin^2(\delta / 2)}$$

A maximum is where  $\delta / 2 \approx m\pi + \delta' / 2$  and  $\sin^2(\delta / 2) \approx \delta' / 2$

Under these conditions (near resonance),

$$T = \frac{1}{1 + F\delta'^2 / 4}$$

This is a Lorentzian profile, with FWHM at:

$$\frac{F}{4} \left( \frac{\delta_{LW}}{2} \right)^2 = 1 \Rightarrow \delta_{LW} \approx 4 / \sqrt{F}$$

This transmission linewidth corresponds to the minimum resolvable wavelength.

# Etalon Finesse

The Finesse,  $\mathfrak{F}$ , is the ratio of the Free Spectral Range and the Linewidth:

$$\mathfrak{F} \equiv \frac{\delta_{FSR}}{\delta_{FW}} = \frac{2\pi}{4/\sqrt{F}} = \frac{\pi\sqrt{F}}{2}$$

$\delta = 2\pi$  corresponds to one FSR

Using:  $F = \left[ \frac{2r}{1-r^2} \right]^2$

$$\mathfrak{F} = \frac{\pi}{1-r^2}$$

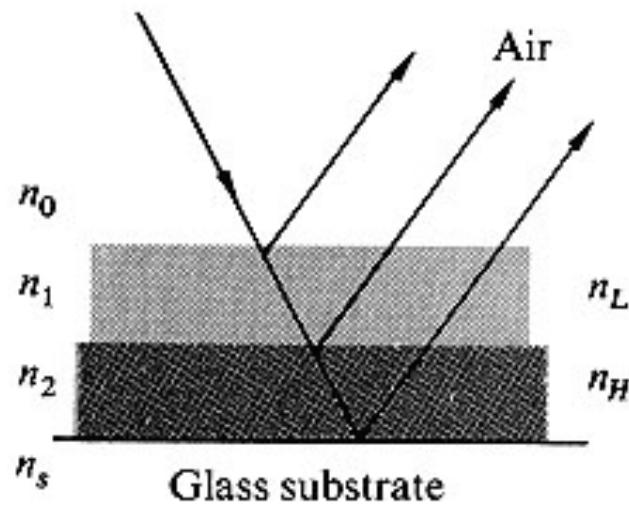
taking  $r \approx 1$

The Finesse is the number of wavelengths the interferometer can resolve.

# Multilayer coatings

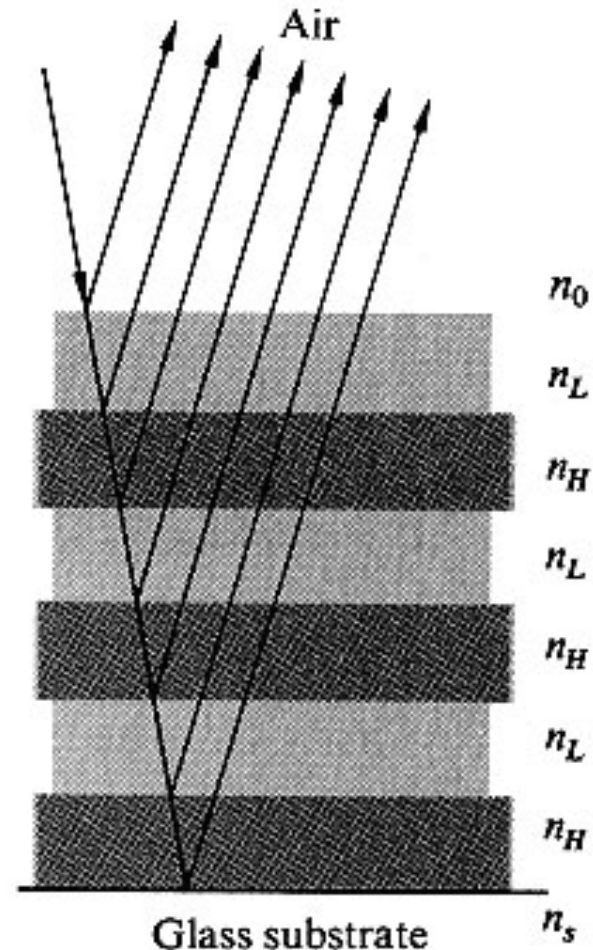
Typical laser mirrors and camera lenses use many layers.

The reflectance and transmittance can be custom designed



$$gHL a$$

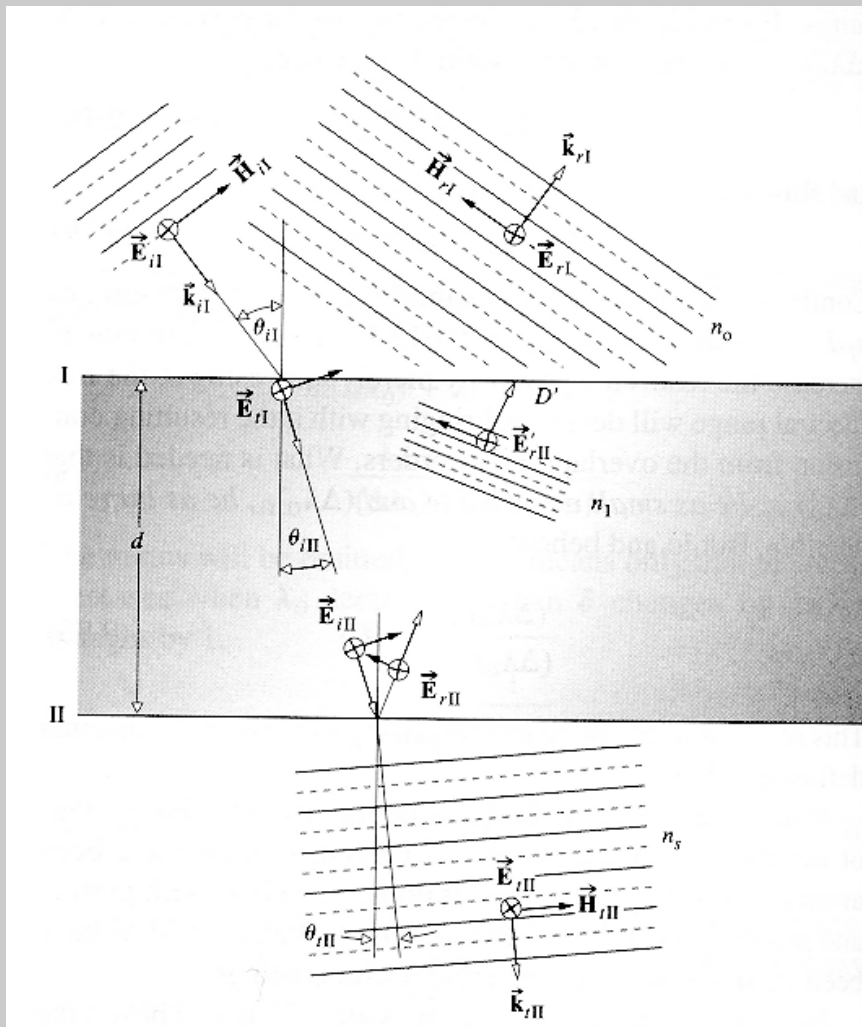
Double-quarter



$$gHLHLHL a$$
$$g(HL)^3 a$$

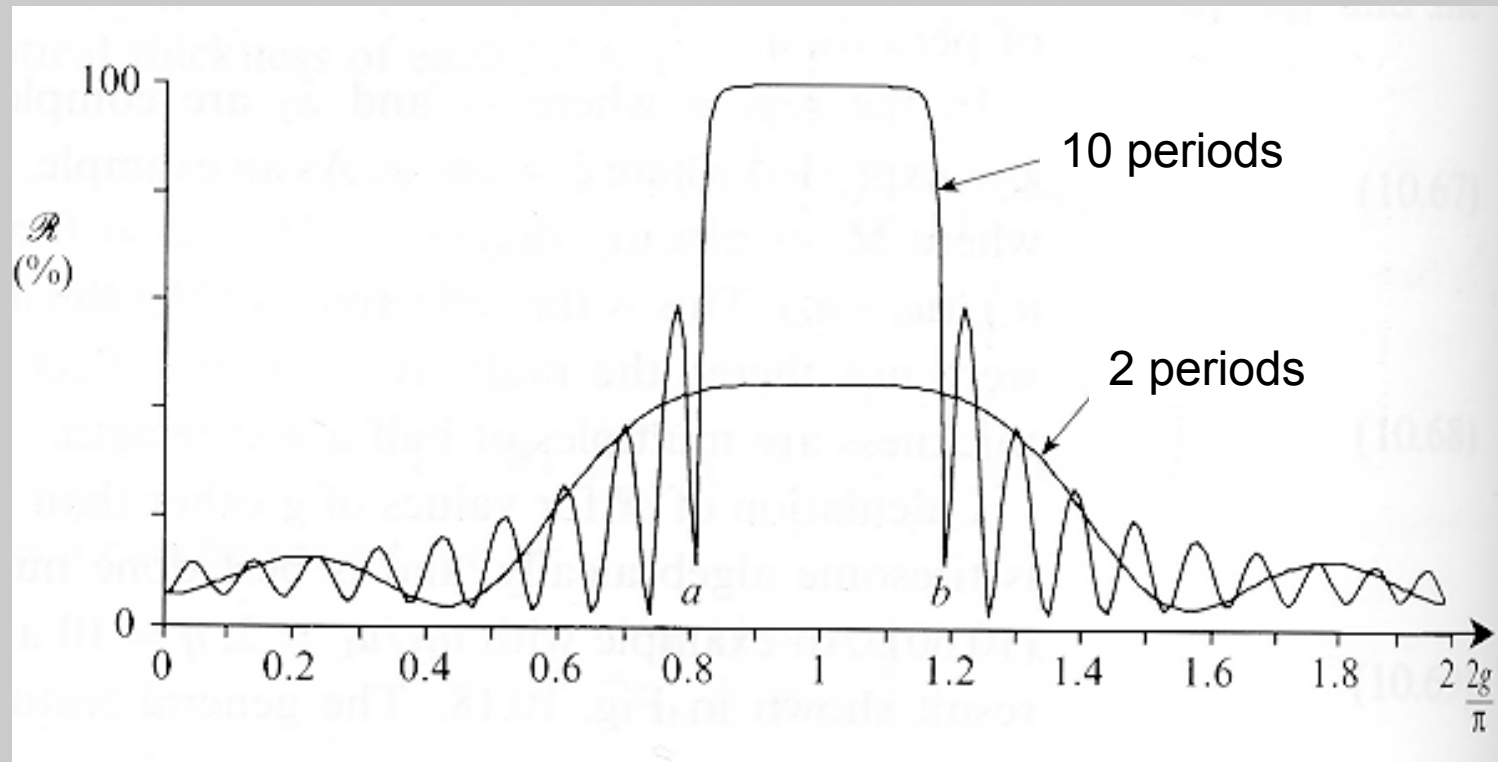
Quarter-wave stack

# Multilayer thin-films: wave/matrix treatment



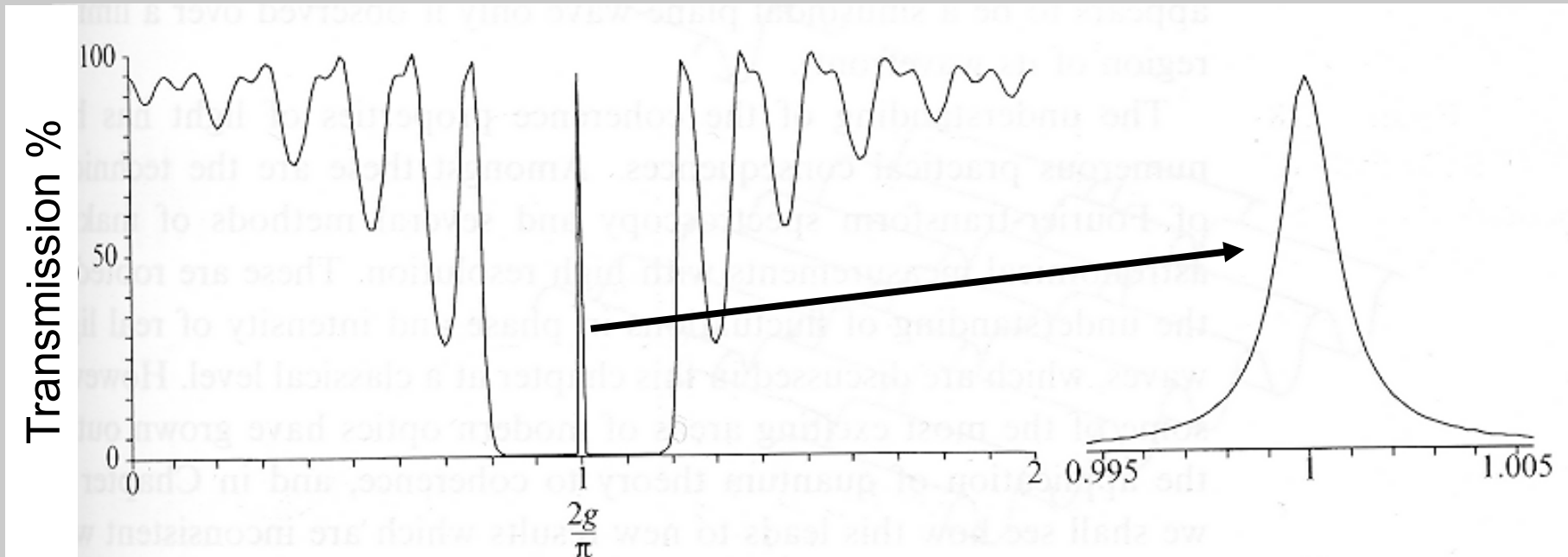
- Use boundary conditions to relate fields at the boundaries
- Phase shifts connect fields just after I to fields just before II
- Express this relation as a transfer matrix
- Multiply matrices for multiple layers

# High-reflector design



Reflectivity can reach  $> 99.99\%$  at a specific wavelength  
 $> 99.5\%$  for over 250nm  
Bandwidth and reflectivity are better for “S” polarization.

# Interference filter design



- A thin layer is sandwiched between two high reflector coatings
- very large free spectral range, high finesse
- typically 5-10nm bandwidth, available throughout UV to IR